Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | WATANABE ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*-	_	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,941,786	08-1999	Van Wijk et al.	474/18
	В	US-6,120,413	09-2000	Kawamura, Yasutaka	477/50
	С	US-6,217,469	04-2001	Sawada et al.	474/28
	D	US-			
	E	US-		·	
	F	US-		·	
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP (62-83548) A	04-1987	Japan	Honda et al.	474/28
	0	JP (11-166620) A	06-1999	Japan	Okuda et al.	F16H 61/40
	P				-	
	Q					
	R					
	S					
	τ					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.